

# FGL35N120FTD 1200 V, 35 A Field Stop Trench IGBT

### **Features**

- Field Stop Trench Technology
- High Speed Switching
- Low Saturation Voltage: V<sub>CE(sat)</sub> = 1.68 V @ I<sub>C</sub> = 35 A
- High Input Impedance

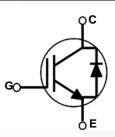
### Applications

• Solar Inverter, UPS, Welder, PFC

## **General Description**

Using advanced field stop trench IGBT technology, Fairchild's 1200V trench IGBTs offer the optimum performance for hard switching application such as solar inverter, UPS, welder applications.





### **Absolute Maximum Ratings**

Symbol	Description		Ratings	Unit	
V <sub>CES</sub>	Collector to Emitter Voltage		1200	V	
V <sub>GES</sub>	Gate to Emitter Voltage		± 25	V	
	Collector Current	@ T <sub>C</sub> = 25°C	70	А	
IC C	Collector Current	@ T <sub>C</sub> = 100 <sup>o</sup> C	35	A	
I <sub>CM (1)</sub>	Pulsed Collector Current	@ T <sub>C</sub> = 25°C	105	A	
I <sub>F</sub>	Diode Continuous Forward Current	@ T <sub>C</sub> = 25 <sup>o</sup> C	80	A	
	Diode Continuous Forward Current	@ T <sub>C</sub> = 100 <sup>o</sup> C	40	A	
P <sub>D</sub>	Maximum Power Dissipation	@ T <sub>C</sub> = 25°C	368	W	
D	Maximum Power Dissipation	@ T <sub>C</sub> = 100 <sup>o</sup> C	147	W	
TJ	Operating Junction Temperature		-55 to +150	°C	
T <sub>stg</sub>	Storage Temperature Range		-55 to +150	°C	
TL	Maximum Lead Temp. for soldering Purposes, 1/8" from case for 5 second	ls	300	°C	

Notes: 1: Repetitive rating: Pulse width limited by max. junction temperature

### **Thermal Characteristics**

Symbol	Parameter	Max.	Unit	
$R_{\theta JC}$ (IGBT)	Thermal Resistance, Junction to Case	0.34	°C/W	
$R_{\theta JC}$ (Diode)	Thermal Resistance, Junction to Case	0.9	°C/W	
$R_{ hetaJA}$	Thermal Resistance, Junction to Ambient	25	°C/W	

Part NumberTop MarkPackageFGL35N120FTDTUFGL35N120FTDTO-264		Packag	je	Packing Method	Reel Size		Tape Width		Quantity	
		4 Tube		N/A		N/A		30		
Electric	al Cha	racteristics o	of the IC	GB.	$T_{C} = 25^{\circ}C$ unless otherwise	noted				
Symbol		Parameter			Test Conditions		Min.	Тур.	Max	. Uni
Off Charac	teristics									
BV <sub>CES</sub>		r to Emitter Breakdow	n Voltage	VG	<sub>Ξ</sub> = 0 V, I <sub>C</sub> = 250 μA		1200	-	-	V
ICES		r Cut-Off Current			$V_{CES}, V_{GE} = 0 V$		-	-	1	mA
I <sub>GES</sub>	G-E Lea	kage Current		$V_{GE} = V_{GES}, V_{CE} = 0 V$			-	-	±250	) nA
010		0								
On Charac	teristics									
V <sub>GE(th)</sub>	G-E Thr	eshold Voltage		I <sub>C</sub> =	= 35 mA, V <sub>CE</sub> = V <sub>GE</sub>		3.5	6.2	7.5	V
					: 35 A, V <sub>GE</sub> = 15 V		-	1.68	2.2	V
V <sub>CE(sat)</sub>	Collector to Emitter Saturation Voltage		$I_{C} = 35 \text{ A}, V_{GE} = 15 \text{ V},$ $T_{C} = 125^{\circ}\text{C}$				2.0	-	V	
Dynamic C	haracter	stics		1						
C <sub>ies</sub>		pacitance					-	5090	-	pF
C <sub>oes</sub>	Output 0	Capacitance		$V_{CE} = 30 V, V_{GE} = 0 V,$		-	-	180	-	pF
C <sub>res</sub>	Reverse	e Transfer Capacitance		f = 1 MHz			-	95	-	pF
Switching	Characte	ristics		1		<b>I</b>				
t <sub>d(on)</sub>		Delay Time					-	34	-	ns
t <sub>r</sub>	Rise Tin	ne					-	63	-	ns
t <sub>d(off)</sub>	Turn-Off	Delay Time		Va	<sub>C</sub> = 600 V, I <sub>C</sub> = 35 A,		-	172	-	ns
t <sub>f</sub>	Fall Tim	8		$R_{G}$	= 10 Ω, V <sub>GE</sub> = 15 V,		-	107	-	ns
E <sub>on</sub>	Turn-On	Switching Loss		Ind	uctive Load, $T_C = 25^{\circ}C$		-	2.5	-	mJ
E <sub>off</sub>	Turn-Off	Switching Loss		İ		F	-	1.7	-	mJ
E <sub>ts</sub>		ritching Loss				F	-	4.2	-	mJ
t <sub>d(on)</sub>	Turn-On	Delay Time						33	-	ns
t <sub>r</sub>	Rise Tin			İ		F		66	-	ns
t <sub>d(off)</sub>	Turn-Off	Delay Time		Vc	<sub>C</sub> = 600 V, I <sub>C</sub> = 35 A,			180	-	ns
t <sub>f</sub>	Fall Tim	e		$R_{G}$	= 10 Ω, V <sub>GE</sub> = 15 V,		-	146	-	ns
E <sub>on</sub>	Turn-On	Switching Loss		Inductive Load, $T_C = 125^{\circ}C$			-	3.1	-	mJ
E <sub>off</sub>	Turn-Off	Switching Loss					-	2.1	-	mJ
E <sub>ts</sub>	Total Sw	ritching Loss				F	-	5.2	-	mJ
Qg	Total Ga	te Charge					-	210	-	nC
Q <sub>ge</sub>		Emitter Charge			$= 600 \text{ V}, \text{ I}_{\text{C}} = 35 \text{ A},$	-	-	42	-	nC
Q <sub>gc</sub>		Collector Charge		VGI	V <sub>GE</sub> = 15 V		-	101	-	nC

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FGL35N120FTD
— 1200 V,
V, 35 A Field
A Field Stop Tre
rench IGBT

Symbol	Parameter	Test Condition	Min.	Тур.	Max	Unit	
V <sub>FM</sub> Diode Forward Voltage	Diode Forward Voltage	I <sub>F</sub> = 35 A	$T_{\rm C} = 25^{\rm o}{\rm C}$	-	2.7	3.4	V
	·F 007.	T <sub>C</sub> = 125°C	-	2.5	-	] ்	
t <sub>rr</sub>	r Diode Reverse Recovery Time		$T_{\rm C} = 25^{\rm o}{\rm C}$	-	337	-	ns A
-11			$T_{C} = 125^{\circ}C$	-	520	-	
I <sub>rr</sub>	Diode Peak Reverse Recovery Current	I <sub>F</sub> = 35 A, di <sub>F</sub> /dt = 200 A/μs	$T_{C} = 25^{\circ}C$	-	7.6	-	
		di <sub>F</sub> /dt = 200 A/µs	$T_{C} = 125^{\circ}C$	-	12.9	-	
Q <sub>rr</sub>	Diode Reverse Recovery Charge		$T_C = 25^{\circ}C$	-	1292	-	nC
∽rr	Diede Hereice Heedvery enarge		$T_{\rm C} = 125^{\rm o}{\rm C}$	-	3377	-	

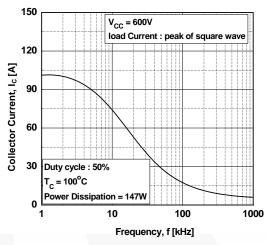
#### **Typical Performance Characteristics Figure 1. Typical Output Characteristics Figure 2. Typical Output Characteristics** 180 180 $T_C = 25^{\circ}C$ T<sub>C</sub> = 125<sup>o</sup>C 17V 17V 20V 20\ 15V 15V 150 150 12V 12V Collector Current, I<sub>c</sub> [A] Collector Current, I<sub>c</sub> [A] 120 120 90 90 10V 10V 60 60 9V 9V 30 30 V<sub>GE</sub> = 8V V<sub>GE</sub> = 8V 0 0 2 4 6 Collector-Emitter Voltage, V<sub>CE</sub> [V] 2 4 6 Collector-Emitter Voltage, V<sub>CE</sub> [V] 0 8 8 0 Figure 3. Typical Saturation Voltage **Figure 4. Transfer Characteristics Characteristics** 120 120 Common Emitter Common Emitter $V_{CE} = 20V$ $V_{GE} = 15V$ 100 100 $T_C = 25^{\circ}C$ $T_{C} = 25^{\circ}C$ — Collector Current, I<sub>c</sub> [A] Collector Current, I<sub>c</sub> [A] T<sub>C</sub> = 125<sup>o</sup>C .... T<sub>C</sub> = 125<sup>o</sup>C ... 80 80 60 60 40 40 20 20 0 0 0 1 2 3 8 10 12 4 4 6 Collector-Emitter Voltage, V<sub>CE</sub> [V] Gate-Emitter Voltage, VGE [V] Figure 6. Saturation Voltage vs. V<sub>GE</sub> Figure 5. Saturation Voltage vs. Case **Temperature at Variant Current Level** 2.8 20 Common Emitter Common Emitter 70A V<sub>GE</sub> = 15V $T_{C} = 25^{\circ}C$ Collector-Emitter Voltage, V<sub>CE</sub> [V] 2.6 Collector-Emitter Voltage, V cE [V] 16 2.4 2.2 12 2.0 35A 8 1.8 70Å 35A 1.6 I<sub>C</sub> = 18A 4 1.4 I<sub>C</sub> = 18A 0 ∟ 4 1.2 50 75 100 125 20 25 8 12 16 Case Temperature, $T_C$ [°C] Gate-Emitter Voltage, VGE [V]

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### Figure 7. Saturation Voltage vs. V<sub>GE</sub> 20 Common Emitter $T_C = 125^{\circ}C$ $\geq$ 16 Collector-Emitter Voltage, V<sub>CE</sub> Collector Current, I<sub>c</sub> [A] 12 8 70A 35A 4 $I_{\rm C} = 18A$ 0 8 20 4 12 16 Gate-Emitter Voltage, V<sub>GE</sub> [V] **Figure 9. Capacitance Characteristics** 8000 Common Emitter V<sub>GE</sub> = 0V, f = 1MHz Cies T<sub>C</sub> = 25°C 6000 Capacitance [pF] 4000 C<sub>oes</sub> 2000 Cres 0 1 10 30 Collector-Emitter Voltage, V<sub>CE</sub> [V] Figure 11. SOA Characteristics 400 100 10µs Collector Current, Ic [A] 10 100µs Ims 1 10 ms DC \*Notes: 0.1 1. $T_{C} = 25^{\circ}C$ 2. $T_J = 150^{\circ}C$

**Typical Performance Characteristics** 

### Figure 8. Load Current vs. Frequency





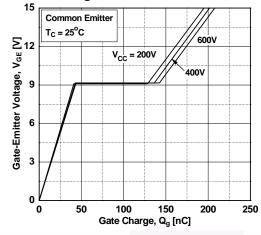
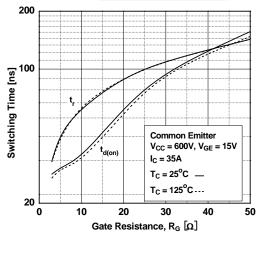


Figure 12. Turn-on Characteristics vs. Gate Resistance



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0.01

1

3. Single Pulse

10

100

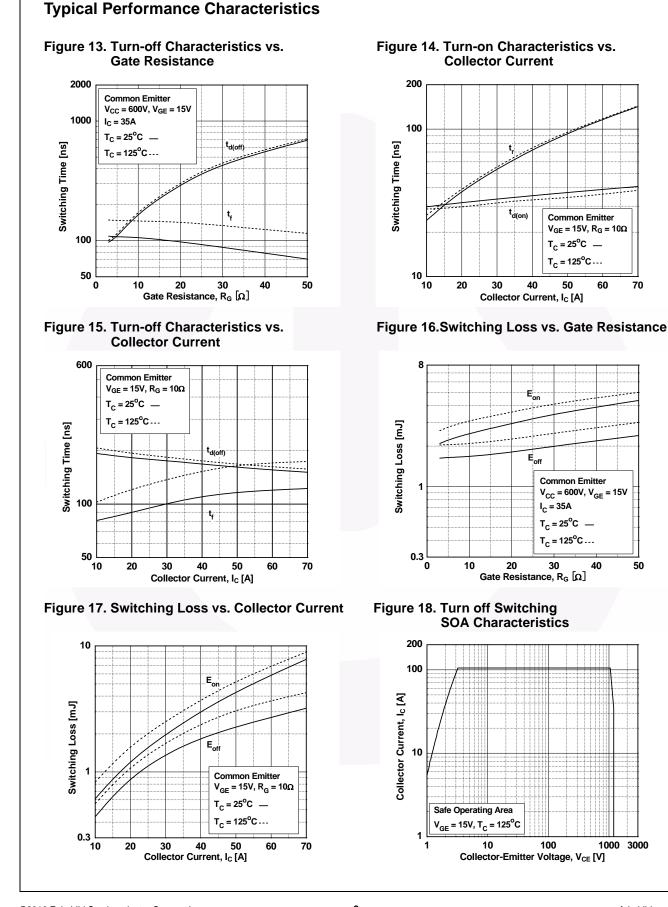
Collector-Emitter Voltage, V<sub>CE</sub> [V]

1000

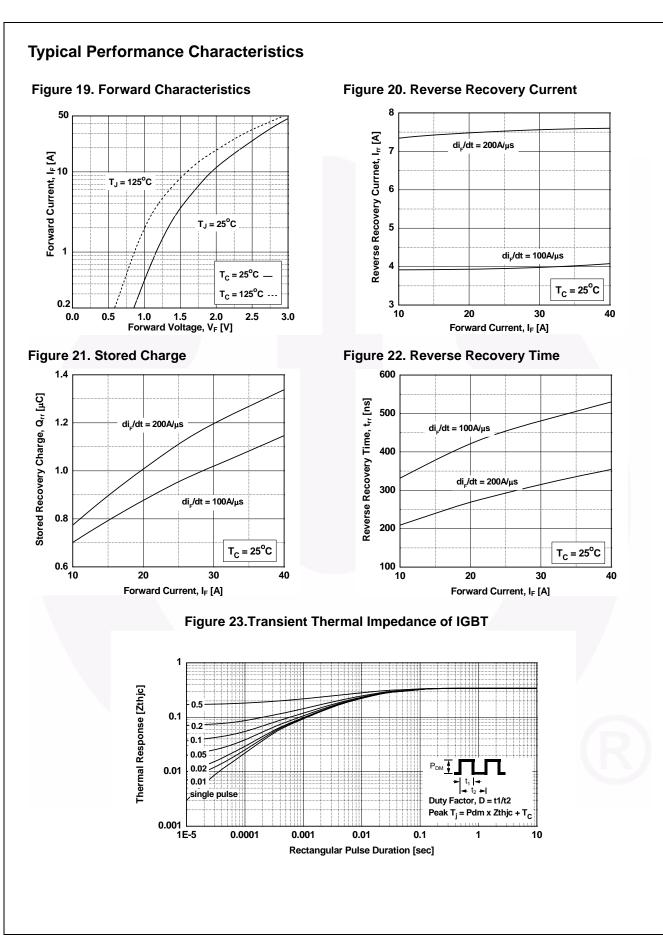
4000

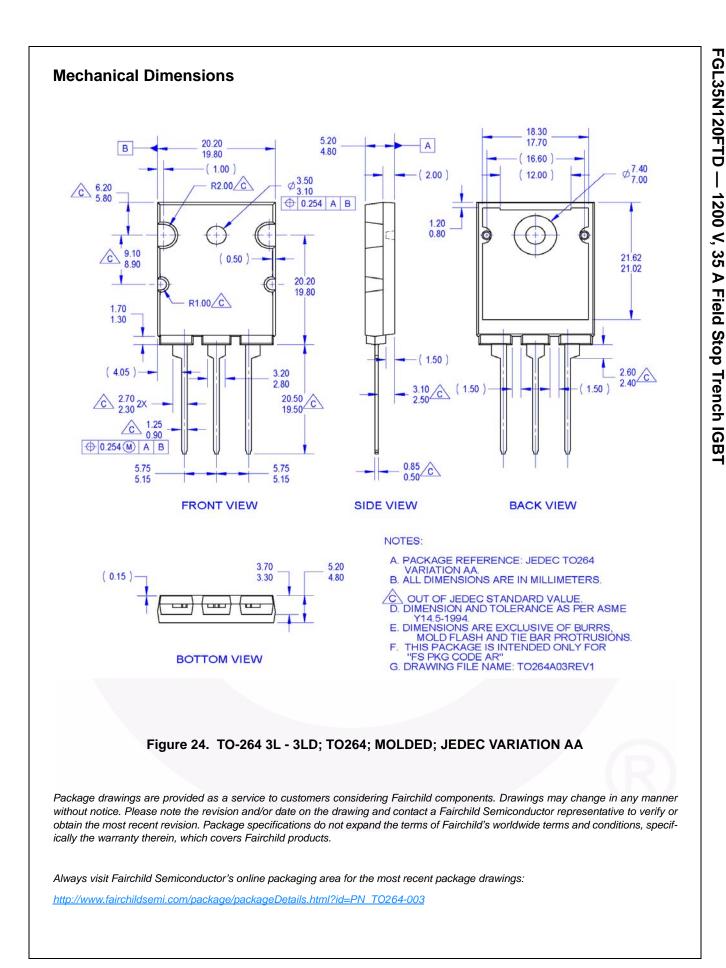
70

50



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